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JOINT INDUSTRY STANDARD

Moisture/Reflow
Sensitivity Classification
for Nonhermetic Surface
Mount Devices







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Moisture/Reflow **Sensitivity Classification** for Nonhermetic Surface **Mount Devices**

A joint standard developed by the IPC Plastic Chip Carrier Cracking Task Group (B-10a) and the JEDEC JC-14.1 Committee on Reliability Test Methods for Packaged Devices

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IPC/JEDEC J-STD-020A -

April 1999 J-STD-020 - October 1996 JEDEC JESD22-A112 IPC-SM-786A - January 1995

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Users of this standard are encouraged to participate in the development of future revisions.

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